

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Inventors:

Blaine R. Spady; John D. Heaton

Assignee:

Nanometrics Incorporated

Title:

Metrology/Inspection Positioning System

Serial No.:

09/458,123

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December 8, 1999

Examiner:

Gordon Stock

Group Art Unit:

2877

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NAN035 US

Confirmation No.:

8470

Santa Clara, California October 8, 2004

Mail Stop Amendment Commissioner For Patents P.O. Box 1450 Alexandria, VA 22313-1450

## RESPONSE TO OFFICE ACTION

## Dear Sir:

This Response to Office Action is responsive to the July 12, 2004, Office Action, which has a statutorily shortened period for response that ends October 12, 2004. Please enter the following amendments before taking action on the merits of the above-referenced application.

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